

Supplementary Material

Construction of Z-scheme heterojunction with Camellia-like

MnCo₂O₄/TiO₂ for photogenerated cathodic protection

Yanan Sun^{a,d}, Xiutong Wang^{a,d}*, Congtao Sun^a, Shengxun Yao^b, Mingxing Wang^a,
Jiayan Pu^a, Youbo Nan^a, Jingshun He^a, Xi Chen^a, Yanliang Huang^a, Fanglin Du^c

^a Key Laboratory of Advanced Marine Materials, Key Laboratory of Marine Environmental Corrosion and Bio-fouling, Institute of Oceanology, Chinese Academy of Sciences, Qingdao 266071, China

^b Institute of Marine Corrosion Protection, Guangxi Key Laboratory of Marine Environmental Science, Guangxi Academy of Sciences, Nanning 530007, China

^c College of Materials Science and Engineering, Qingdao University of Science and Technology, Qingdao 266042, China

^d University of Chinese Academy of Sciences, Beijing 100049, China

* Corresponding author: Xiutong Wang, E-mail: wangxiutong@qdio.ac.cn

Reagents and materials

Ti foil (99.96% purity), 304SS, Ammonium fluoride (NH₄F), sodium sulfide (Na₂S·9H₂O), sodium chloride (NaCl), sodium hydroxide (NaOH), glycol, manganese acetate tetrahydrate ((CH₃COO)₂Mn·4H₂O), Cobalt acetate tetrahydrate ((CH₃COO)₂Co·4H₂O), polyvinyl pyrrolidone (PVP), nitric acid and 30% hydrogen peroxide (H₂O₂) were obtained from Sinopharm Chemical Reagent Co., Ltd. All existing reagents are AR. Ultrapure water is taken from the Flom ultrapure water system (Qingdao, China). Saturated calomel electrode and platinum foil electrode were purchased from Tianjin Aida Hengsheng Technology Co., Ltd. (Tianjin, China).

Characterization methods

The morphology and structure of the samples were characterized by scanning electron microscopy (SEM, Hitachi, S-4800, Japan) and transmission electron microscopy (TEM, JEM-2100P, Japan). X-ray diffraction (XRD, Bruker D8ADVANCE, Germany) was used to study the crystal structure of samples. X-ray photoelectron spectroscopy (XPS, Thermo Escalab 250Xi, USA) was used to detect the surface element composition and valence states of samples, and in situ XPS technology was used to study the electron transfer process on the surface of composite materials before and after irradiation. The light absorption characteristics of the sample were characterized by UV-vis diffuse reflectance spectroscopy (UV-vis DRS, Hitachi U-3900H, Japan). Ultraviolet photoelectron spectroscopy (UPS) can obtain information on the work function, energy level structure, and other aspects of solids. A 300 W high-pressure xenon lamp (PLS-SXE 300C, Beijing Perfectlight, China) equipped with a 420 nm filter simulated visible light, and the light intensity was $320 \text{ mW}\cdot\text{cm}^{-2}$.

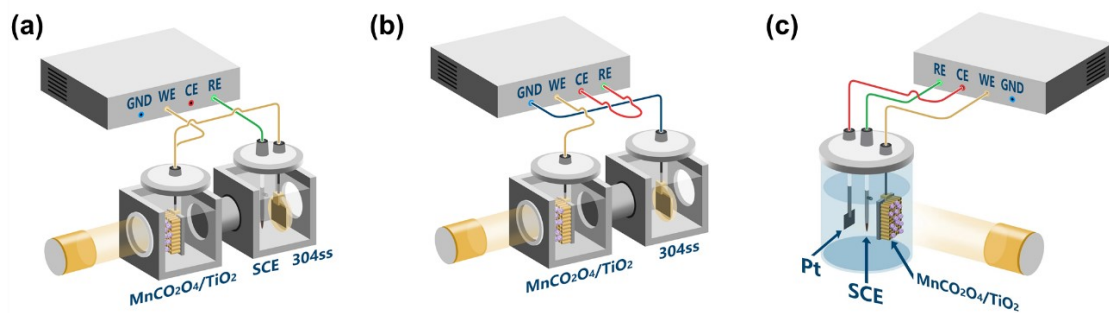


Fig. S1 Photochemical test device diagram, (a) for OCP; (b) for i-t; (c) for i-V and EIS.

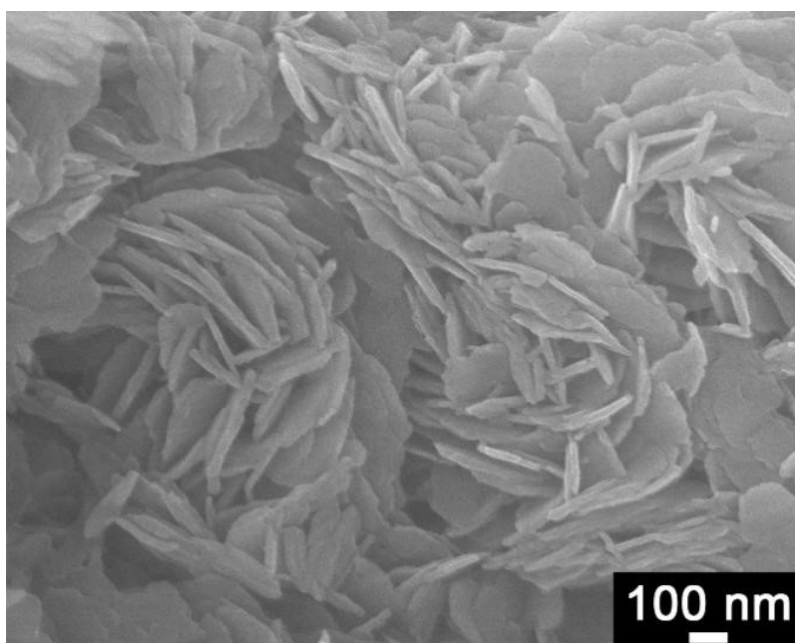


Fig. S2 SEM image of MnCo_2O_4 before sintering.

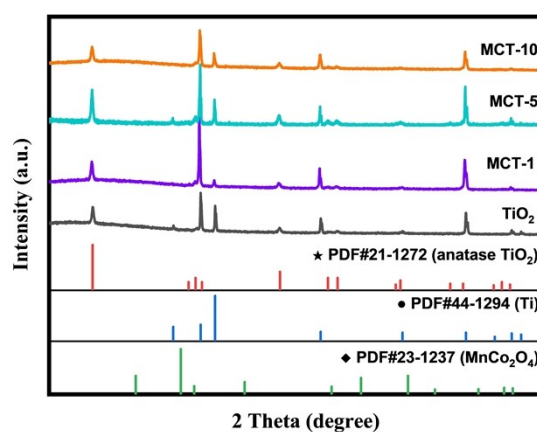


Fig. S3 Pure TiO_2 , MCT-1, MCT-5, and MCT-10 XRD patterns.

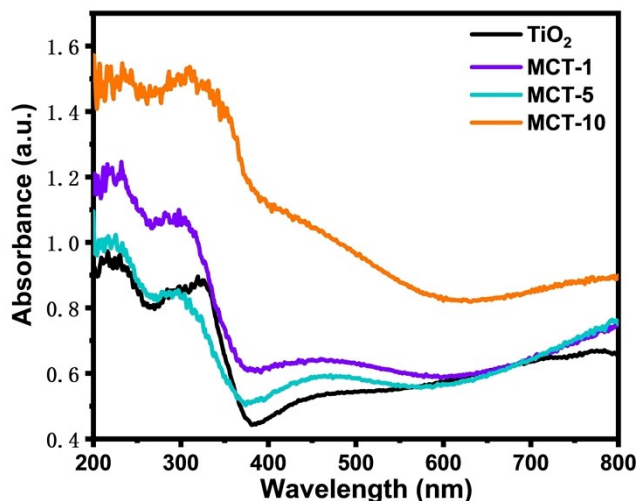


Fig. S4 UV-vis DRS absorption spectra of pure TiO_2 , MCT-1, MCT-5 and MCT-10.

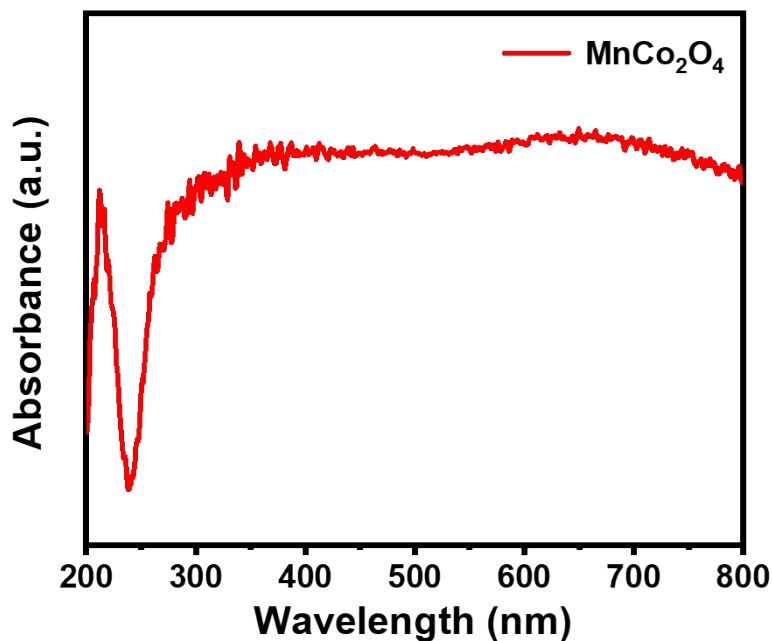


Fig. S5 UV-vis DRS absorption spectra of pure MnCo_2O_4 .

Note 1

The main reasons for the errors in fluorescence lifetime are divided into the following parts:

(1) The empirical formula is a polynomial, hence the number of undetermined parameters varies.

(2) The graphical representation of the empirical formula, the former is a straight line, while the latter is a parabola.

(3) Under the method of least squares, a system of linear equations regarding the undetermined parameters is obtained, the former being of the second order, and the latter of the third order.

Single-exponential function :

$$I(t) = I_0 \exp\left(-t/\tau\right)$$

$$I(t) = I_0 + A_1 \exp\left(-t/\tau_1\right) + A_2 \exp\left(-t/\tau_2\right)$$

$$\tau = (A_1\tau_1^2 + A_2\tau_2^2)/(A_2 \exp\left(-t/\tau_2\right))$$

Double-exponential function :

$$I = A_1 \exp\left(-\frac{t}{\tau_1}\right) + A_2 \exp\left(-\frac{t}{\tau_2}\right) + A_3 \exp\left(-\frac{t}{\tau_3}\right)$$

Triple-exponential function :

$$\tau_{avg} = \frac{A_1\tau_1^2 + A_2\tau_2^2 + A_3\tau_3^2}{A_1\tau_1 + A_2\tau_2 + A_3\tau_3}$$

Table S1 ICP-MS for different MCT

Sample	Element	Mass percentage (%)
MCT-1	Co	0.723
	Mn	0.562
	Ti	67.743
MCT-5	Co	0.691
	Mn	0.623
	Ti	58.671
MCT-10	Co	0.578
	Mn	0.612
	Ti	65.132